

<b>Notice of References Cited</b>	Application/Control No. 10/535,668	Applicant(s)/Patent Under Reexamination YAMANE, HIDEKI	
	Examiner Fred M. Teskin	Art Unit 1713	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0107332	08-2002	Klosiewicz et al.	525/333.3
	B	US-			
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	D	US-			
	E	US-			
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**FOREIGN PATENT DOCUMENTS**

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